

<b>Notice of References Cited</b>	Application/Control No. 09/580,808	Applicant(s)/Patent Under Reexamination SEZAN ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,594,699	07-2003	Sahai et al.	709/228
	B	US-6,611,876	08-2003	Barrett et al.	709/246
	C	US-6,426,761	07-2002	Kanevsky et al.	345/788
	D	US-6,593,936	07-2003	Huang et al.	345/619
	E	US-5,550,965	08-1996	Gabbe et al.	715/512
	F	US-6,317,718	11-2001	Fano, Andrew Ernest	705/1
	G	US-6,543,053	04-2003	Li et al.	725/88
	H	US-6,412,008	06-2002	Fields et al.	709/228
	I	US-6,049,821	04-2000	Theriault et al.	709/203
	J	US-6,426,974	07-2002	Takahashi et al.	375/240.03
	K	US-6,185,625	02-2001	Tso et al.	709/247
	L	US-6,198,767	03-2001	Greenfield et al.	375/240.01
	M	US-6,487,390	11-2002	Virine et al.	455/3.01

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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